MachineLearning manuscript No.
(will be inserted by the editor)

Exact and empirical estimation of misclassification probability

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arXiv:1408.3332v1 [stat.ML] 14 Aug 2014

Received: date / Accepted: date

Abstract We discuss the problem of risk estimation in the classification problem, with specific focus on finding distributions that maximize the confidence intervals of risk estimation. We derived simple analytic approximations for the maximum bias of empirical risk for histogram classifier. We carry out a detailed study on using these analytic estimates for empirical estimation of risk.

Keywords data mining · machine learning · misclassification probability · overfitting · confidence interval · statistical estimate

1 Introduction

The study of overfitting is one of the most important research directions in the area of machine learning. This problem arises from common disadvantage of more complex decision rules relative to the simpler ones when the sample size is not very large. In order to choose the optimal complexity of the method one needs to be able to estimate the quality of solution without using the test sample.

In classification problems, or pattern recognition problems, the quality of solutions is characterized by the misclassification probability (or by more general notion of risk). Thus, what one needs is the ability to estimate risk as precisely and reliably as possible, for given training sample and classification method.

The estimations of risk are carried out either in point or interval form. In the former category there are the methods of empirical risk, cross validation estimation, bootstrap and so on. The quality of point estimation is naturally characterized by the mean quadratic deviation from the estimated quantity. This characteristic allows to compare different estimations and select the best. It does not however provide sufficient information on how reliable the numerical estimation of risk in

The work is supported by RFBR, grants 10-01-00113-a, 11-07-00346-a.

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given problem is. The latter requires the construction of interval form estimations. Among these, the best known is the Vapnik–Chervonenkis estimation [1].

There are many studies devoted to the construction and refinement of risk estimation, conducted in the context of various approaches. These approaches are well known, and we will not enumerate them here as many good reviews already exist [4]. But the main reason why we do not discuss these approaches is that this paper is focused on a problem being substantially different from the subject of mentioned works.

The subject of this paper is not refinement of risk estimation in general case, but finding the exact (tight) bound for special case. Saying about an exact bound we mean that one can find an example where real risk is equal to estimated one. So the Vapnik and Chervonenkis estimates are (nearly) tight because such example exists, see chapter 4 in [4].

This means that one may improve VC–estimates only making some additional assumptions. First, let us list the assumptions of original VC–approach:

1) The distribution the sample was drawn from is unknown.

2) The only statistic we may use is empirical risk.

3) The only information we have about the classification method is the complexity measure (VC-dimension or equivalent).

Under these conditions VC–estimates are (nearly) tight.

Instead of 3 we shall consider particular classification method, namely histogram classifier.

In this paper, we develop an approach based on the explicit finding of distributions for which the error bounds of the estimations are maximum. This does not mean however that we will be primarily oriented toward "the worst case" scenario in terms of expected quality of classification. As is well known, analytically constructed "worst" cases are seldom realized in practice (well known example is the simplex method that quickly solves most practical problems, although there are examples that require exponential time). However, large error bounds do not imply high risk, and the distributions with maximal error bounds are by no means "bad". Rather to the contrary, it is with these "bad" distributions that we can very accurately estimate the probability of misclassification.

Note that the Vapnik–Chervonenkis estimation is unduly pessimistic because of the fact that they "focus on the worst case scenario". The key point here is not that one assumes the "worst case" distribution, but rather that any classification method, including those whose classifiers are maximally different (not taking into account the "similar classifier" effect) are allowed [7].

As will be shown below, the distribution that delivers maximum bias of empirical risk for the histogram classifier (the bias in the estimation is the main contributor to its error) is quite typical.

The histogram classifier is convenient for the study because it allows us to make analytical calculations [3], provides simplicity in the method of classification, and does not have any extra features which could potentially improve estimates.

In [5] the maximum bias of the empirical risk of the histogram classifier was obtained in the asymptotic case. The result is based on the proof of the assertion that the maximum bias of empirical risk is achieved by a piecewise-constant distribution. The assumption was made of distribution having no more than three areas of constancy, which makes it possible to find such a distribution by numerical optimization.

In this paper, the result is extended to finite samples. We also present the explicit form of the distribution, for which we obtain a maximum bias of the empirical risk. Finally, we find simple formulas that approximate the needed dependency with sufficient precision.

We study the possibility of using these results to obtain empirical estimations of risk. In this context, we define as empirical the estimations, the properties of which are not proven but established empirically, using in particular, statistical modeling methods. Note that the estimations that are most widely used in practice are empirical. Take as an example the estimation by the cross validation: its error bound has not been theoretically estimated in general case, but practical experience of solving problems allows to recommend this estimation.

2 Formulation of the problem

Let us consider the general formulation of the problem of decision rule construction (pattern recognition, supervised classification).

Let X be the space of possible values of features (predictors) and Y – the space of possible values of features to be predicted. Let C be the set of all probabilistic measures on a given σ-algebra of subsets of $D = X \times Y$. For each $c \in C$ there is a probabilistic space $\langle D, \mathfrak{B}, \mathsf{P}_c \rangle$ where $\mathfrak{B}$ is a σ-algebra, and P_c a probabilistic measure. Subscript c was introduced for further usage as a short notation of certain probabilistic measure.

A decision function (rule) is defined as $\lambda\colon X \to Y$.

A quality of a decision function is measured by the loss function: $\mathcal{L}\colon Y^2 \to [0, \infty)$.

A risk is defined as the expected (average) loss

$$R(c, \lambda) = \mathsf{E}\mathcal{L}(y, \lambda(x)) = \int \mathcal{L}(y, \lambda(x))\mathsf{P}(dx, dy).$$

In this paper we use the simplest loss function $\mathcal{L}(y, y') = \left\{ \begin{smallmatrix} 0, & y=y' \\ 1, & y \neq y' \end{smallmatrix} \right.$. In this case a risk is a misclassification probability.

Note that risk depends on a distribution that is unknown, so it is necessary to estimate a risk with a sample.

Let $V_N = \left((x^i, y^i) \in D \,|\, i = 1, \ldots, N\right)$ be a random independent identically distributed (i.i.d.) sample from distribution P_c, $V_N \in D^N$. In most cases the size of the sample N will be fixed, so we will drop this subscript in the notation of the sample.

There are many single-value risk estimates: empirical risk (resubstitution error), leave-one-out estimate (special case of cross-validation), bootstrap etc.

We define empirical risk as the average loss on the sample:

$$\widetilde{R}(V, \lambda) = \frac{1}{N} \sum_{i=1}^{N} \mathcal{L}(y^i, \lambda(x^i)).$$

Let $Q\colon D^N \to \Lambda$ be an algorithm (method) for constructing decision functions and $\lambda_{Q,V}$ – the function constructed on sample V by Q. Here Λ is a given class of decision functions.

The Leave-one-out estimate is defined as

$$\breve{R}(V,Q) = \frac{1}{N}\sum_{i=1}^{N}\mathcal{L}(y^i, \lambda_{Q,\breve{V}^i}(x^i)),$$

where $\breve{V}^i = V\backslash\{(x^i,y^i)\}$ is a sample produced from V by removing the i-th observation.

This estimate is nearly unbiased since

$$\mathsf{E}\breve{R}(V_N,Q) = \mathsf{E}R(c,\lambda_{Q,V_{N-1}}),$$

where an expectation is taken over all samples of given size (N and $N-1$ correspondently).

Although leave-one-out rate is a nearly unbiased risk estimate, we may not use it immediately as an expected (predicted) risk value. For example, if we get $\breve{R} = 0$, then we have no reason to expect that the misclassification probability on new objects will be zero. By estimating misclassification probability as null we assert that the classifier will not make errors on new objects. However, in the general case, it is not possible to prove this statement by a finite sample.

In general, a single-value risk estimate is some function of the sample.

A method $\widetilde{Q}$ that provides $\lambda_{\widetilde{Q},V} = \arg\min_{\lambda\in\Lambda}\widetilde{R}(V,\lambda)$ is called an empirical risk minimization method.

A bias of an empirical risk is defined as

$$S(c) = F(c) - \widetilde{F}(c),$$

where $F(c) = \mathsf{E}R(c,\lambda_{Q,V})$, $\widetilde{F}(c) = \mathsf{E}\widetilde{R}(V,\lambda_{Q,V})$. Note that both the means in $F(c)$ and $\widetilde{F}(c)$ are made on all possible decision functions, since the dependency of $\widetilde{F}$ on c is implicitly included in V.

The maximal bias of empirical risk is

$$\hat{S}(\widetilde{F}_0) = \max_{c:\ \widetilde{F}(c)=\widetilde{F}_0} S(c). \tag{1}$$

Here $\widetilde{F}_0$ is some chosen value of empirical risk.

Note that we are interested in a conditional maximum, because in practice we have a certain value of empirical risk calculated for given data. Then by substituting this value as $\widetilde{F}_0$ we get a reasonable estimate of maximal risk bias for the data.

3 Histogram classifier

3.1 Description

Let X be discrete, i.e. $X = \{1,\dots,k\}$ and decision function minimizes an empirical risk in each $x \in X$. In this case a probabilistic measure $c \in C$ can be defined by a matrix of parameters

$$c = (c_j | j = 1,\dots,k)\,, \quad c_j = (\alpha_j, p_j),$$

where $\alpha_j = \mathsf{P}(x = j)$, $p_j = \mathsf{P}(y = 1|x = j)$.

For a sample V of size N let n_j be a number of sample points with $x = j$ and m_j be a number of points with $x = j$ and $y = 1$. So a sample is defined as a set of pairs $v_j = (m_j, n_j)$, i.e. $V = \{v_j | j = 1, \ldots, k\}$. To describe a sample we shall also sometimes say that in a "cell" j there are m_j points of the first class and $n_j - m_j$ points of the zero class.

Consider the algorithm $\widetilde{Q}$ that minimizes an empirical risk in each $x \in X$, i.e. $\lambda_{\widetilde{Q},V}(j) = 0$, when $n_j - m_j > m_j$, $\lambda_{\widetilde{Q},V}(j) = 1$, when $n_j - m_j < m_j$, and $\lambda_{\widetilde{Q},V}(j)$ takes randomly 1 or 0, when $n_j - m_j = m_j$.

There is polynomial distribution on samples that allows analytical averaging of some sample functions.

3.2 Expectation of additive functions

In order to find the risk bias we need to calculate risk and empirical risk expectations.

Let $f(V, c) = \sum_{j=1}^{k} \varphi(v_j, c_j) = \sum_{j=1}^{k} \varphi(m_j, n_j, \alpha_j, p_j)$ be an additive function of a sample and of a distribution. Then $\mathsf{E}f(V, c) = \sum_{j=1}^{k} \mathsf{E}\varphi(v_j, c_j)$.

Denote $B(m, n, p) = C_n^m p^m (1 - p)^{n-m}$ – Binomial distribution.

Let us introduce $\mu_\varphi(c) \equiv \mu_\varphi(\alpha, p) = \mathsf{E}\varphi(v, c)$.

We can directly (or by summation of multinomial distribution) obtain

$$\mu_\varphi(\alpha, p) = \sum_{n=0}^{N} B(n, N, \alpha) \sum_{m=0}^{n} B(m, n, p)\varphi(m, n, \alpha, p) = \\ = \sum_{n=0}^{N} B(n, N, \alpha)\pi_\varphi(n, \alpha, p), \quad (2)$$

where $\pi_\varphi(n, \alpha, p) = \sum_{m=0}^{n} B(m, n, p)\varphi(m, n, \alpha, p)$.

Finally,

$$\mathsf{E}f(V, c) = \sum_{j=1}^{k} \mu_\varphi(c_j).$$

An empirical risk and misclassification probability are additive, namely:

$$\widetilde{R}(V) = \sum_{j=1}^{k} \tilde{r}(m_j, n_j),$$

$$\tilde{r}(m, n) = \frac{1}{N}\tilde{\nu}(m, n), \quad \tilde{\nu}(m, n) = \min(m, n - m);$$

$$R(c, \lambda_{\widetilde{Q},V}) = \sum_{j=1}^{k} r(m_j, n_j, \alpha_j, p_j),$$

$$r(m, n, \alpha, p) = \alpha\nu(m, n, p), \quad \nu(m, n, p) = \begin{cases} 1-p, & m>n-m \\ p, & m<n-m \\ 0.5, & m=n-m \end{cases}.$$

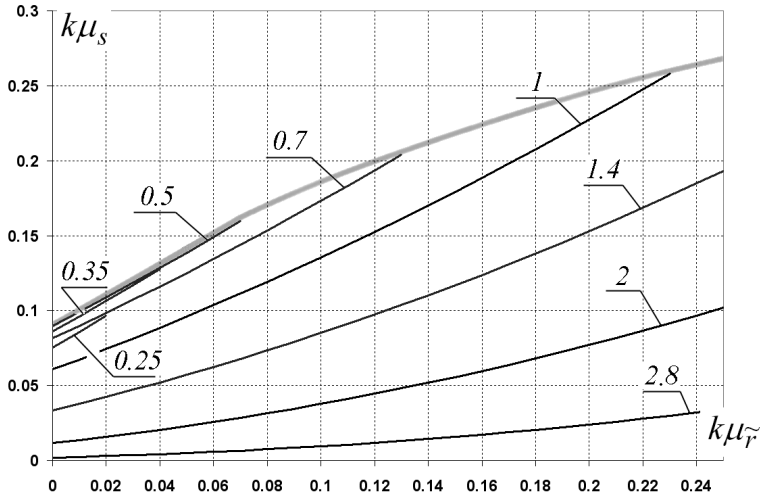

Fig. 1 Dependencies for risk on a "cell".

3.3 Finding maximal bias

The task (1) for histogram classifier case has the form:

$$\sum_{j=1}^{k} \mu_s(\alpha_j, p_j) \to \max_{\alpha_j, p_j}, \tag{3}$$

with constraints:

$$\sum_{j=1}^{k} \mu_{\tilde{r}}(\alpha_j, p_j) = \widetilde{F}_0, \quad \sum_{j=1}^{k} \alpha_j = 1, \quad 0 \le p_j \le 1.$$

Here $\mu_s(\alpha, p)$ and $\mu_{\tilde{r}}(\alpha, p)$ are defined by formula (2) with correspondent substitution $s(m, n, \alpha, p) = r(m, n, \alpha, p) - \tilde{r}(m, n)$ and $\tilde{r}(m, n)$ instead of $\varphi(m, n, \alpha, p)$.

Figure 1 shows dependences $k\mu_s$ on $k\mu_{\tilde{r}}$ for different $k\alpha$, when $N = 20$, $k = 10$.

Let $\zeta(z) = k \max_{k\mu_{\tilde{r}}=z} \mu_s$ be the envelope of the plotted curves. On figure 1 it is shown as thick grey curve.

One can show that the maximal bias differs from $\zeta(\widetilde{F}_0)$ less than by $\frac{1}{k} + 0.01 \cdot \zeta(\widetilde{F}_0)$. The proof is based on the following.

Let us consider the task (3) without the constraint $\sum_{j=1}^{k} \alpha_j = 1$. Then it may be transformated to the equivalent form:

$$\sum_{j=1}^{k} \zeta(z_j) \to \max_{z_j}, \tag{4}$$

with constraints: $\sum_{j=1}^{k} z_j = \widetilde{F}_0$, $0 \le z_j \le 1$.

Suppose $\zeta(z)$ to be concave, i. e. $\zeta''(z) < 0$. Then the maximum in (4) is attained when the all z_j are equal. Hence $\zeta(\widetilde{F}_0)$ would be a solution of problem (3)

without the constraint $\sum_{j=1}^{k} \alpha_j = 1$. The maximal bias appears when the all α_j are equal, but their sum may be less than 1.

However one can easily keep the constraint $\sum_{j=1}^{k} \alpha_j = 1$ by setting all extra probability to any "cell", and setting correspondent $p_j = 0$ so as to provide $\widetilde{F}$ to be unchanged.

In reality $\zeta(z)$ is not concave, but may be very tightly approximated by a concave function. Numerical evaluation shows that the relative error caused by this approximation is less than 0.01.

The form of the envelope curve on figure 1 is typical for $N \geq k$. The left part of the envelope corresponds to p changing from 0 to 0.5 when $\alpha = \frac{1}{N}$. The right part of the envelope corresponds to α changing from $\frac{1}{N}$ to $\frac{1}{k}$ when $p = 0.5$.

The case $N < k$ is simpler and isn't so important in practice, so we do not consider it here. For simplicity let's assume $N \geq k$.

Thus the distribution providing a bias that differs from the supreme bias less than by $\frac{1}{k}$ is of the following form:

$$\alpha_j = \alpha',\ p_j = p',\ \ j = 1, \ldots, k-1,$$
$$\alpha_k = 1 - \frac{k-1}{N},\ p_k = 0.$$

In other words, the "worst" distribution is uniform over all the "cells" except for one cell that accumulates the "excess" probability.

The values α' and p' are determined by the following way.

When $\widetilde{F}_0 \leq \widetilde{F}_T$ we have $\alpha' = \frac{1}{N}$, and p' is calculated via $\widetilde{F}_0$. When $\widetilde{F}_0 \geq \widetilde{F}_T$ we have $p' = 0.5$, and α' is calculated via $\widetilde{F}_0$. Here $\widetilde{F}_T$ is the expectation of empirical risk by $\alpha' = \frac{1}{N},\ p' = 0.5$.

3.4 Approximations

Binomial distribution in (2) may be tightly approximated by Poisson distribution

$$\mu_\varphi(\alpha, p) \approx \rho_\varphi(\gamma, p) = \sum_{n=0}^{N} \frac{\gamma^n}{n!} e^{-\gamma} \pi_\varphi(n, \alpha, p),$$

where $\gamma = N\alpha$.

Since $\pi_{\tilde{r}}(n, \alpha, p) = \frac{1}{N}\pi_{\tilde{\nu}}(n, p)$ and $\pi_r(n, \alpha, p) = \alpha\pi_\nu(n, p)$ we have

$$\rho_{\tilde{r}}(\gamma, p) = \frac{1}{N}\rho_{\tilde{\nu}}(\gamma, p);$$
$$\rho_r(\gamma, p) = \alpha\rho_\nu(\gamma, p) = \frac{\gamma}{N}\rho_\nu(\gamma, p).$$

Functions ν and $\tilde{\nu}$ are defined in section 3.2.

Since for the "worst" distribution c^* the probabilities in all "cells" are the equal except for the last "cell" that does not affect the risks, we obtain

$$\widetilde{F}(c^*) \approx \frac{k-1}{N}\rho_{\tilde{\nu}}(\gamma, p) \approx \frac{1}{M}\rho_{\tilde{\nu}}(\gamma, p),$$
$$F(c^*) \approx \frac{(k-1)\gamma}{N}\rho_\nu(\gamma, p) \approx \frac{\gamma}{M}\rho_\nu(\gamma, p),$$

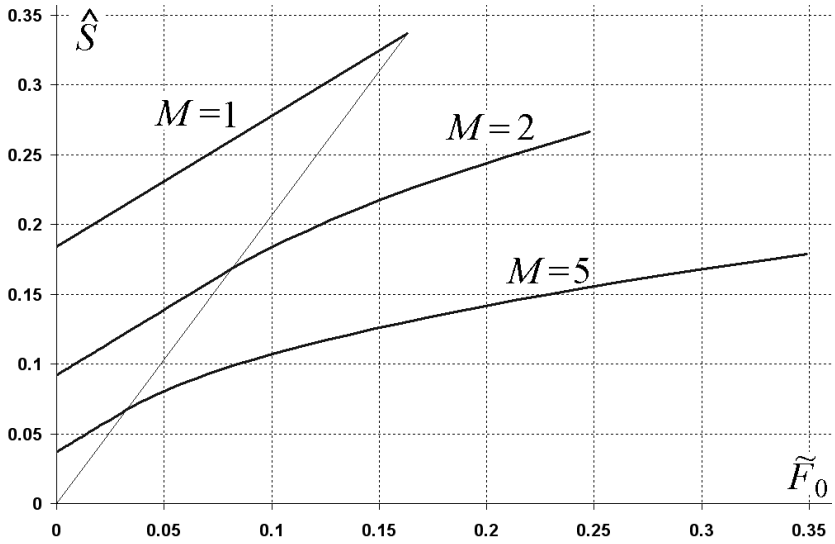

Fig. 2 The maximal bias of empirical risk.

where $M = \frac{N}{k}$ is the average number of sample points per cell, i. e. is the relative sample size.

Let $\tilde{\rho}_1(p) = \rho_{\tilde{\nu}}(1, p)$ and $\tilde{\rho}_2(\gamma) = \rho_{\tilde{\nu}}(\gamma, \frac{1}{2})$.

Let us introduce the function

$$\psi(z) = \begin{cases} \psi_1(z), & 0 \le z \le \Upsilon; \\ \psi_2(z), & z \ge \Upsilon, \end{cases}$$

where $\Upsilon = \rho_{\tilde{\nu}}(1, \frac{1}{2}) \approx 0{,}163$, $\psi_1(z) = \rho_\nu\big(1, p^*(z)\big)$, $p^*(z) = \tilde{\rho}_1^{-1}(z)$, $\psi_2(z) = \gamma^*(z)\rho_\nu\big(\gamma^*(z), \frac{1}{2}\big) = \frac{1}{2}\gamma^*(z)$, $\gamma^*(z) = \tilde{\rho}_2^{-1}(z)$.

When $M \ge 1$ the approximate expression for maximal bias of empirical risk is

$$\hat{S}(\widetilde{F}_0) \approx \frac{1}{M}\psi(M\widetilde{F}_0) - \widetilde{F}_0.$$

This function is defined for those $\widetilde{F}_0$ that provide for the condition $\frac{1}{M}\psi(M\widetilde{F}_0) \le 0.5$.

Figure 2 shows the maximal bias of empirical risk for a different value $M = \frac{N}{k}$. The thin line contains the points of joining ψ_1 and ψ_2.

The function $\psi(z)$ can be easily calculated numerically, however it may be approximated by simple analytical expressions.

As fig. 2 shows, the function $\psi_1(z)$ is close to linear. Since $\psi_1(0) = \frac{1}{2e}$ and $\psi_1(\Upsilon) = 0.5$ one gets a linear approximation $\psi_1(z) \approx \bar{\psi}_1(z) = \frac{1}{2e} + \big(\frac{1}{2} - \frac{1}{2e}\big)\frac{z}{\Upsilon}$.

The function that is inverse to $\psi_2(z)$ can also be easily approximated. It appears that $1 - 2\frac{\tilde{\rho}_2(\gamma)}{\gamma} \approx \frac{1-2\Upsilon}{\sqrt{1+2\gamma}}\sqrt{3}$.

Taking into account $\psi_2(z) = 0{,}5\tilde{\rho}_2^{-1}(z)$ or $\psi_2^{-1}(\frac{\gamma}{2}) = \tilde{\rho}_2(\gamma)$ and putting $t = \frac{\gamma}{2}$ one obtains $\psi_2^{-1}(t) \approx \bar{\psi}_2^{-1}(t) = t \cdot \Big(1 - \frac{1-2\Upsilon}{\sqrt{1+4t}}\sqrt{3}\Big)$, $t \ge \frac{1}{2}$.

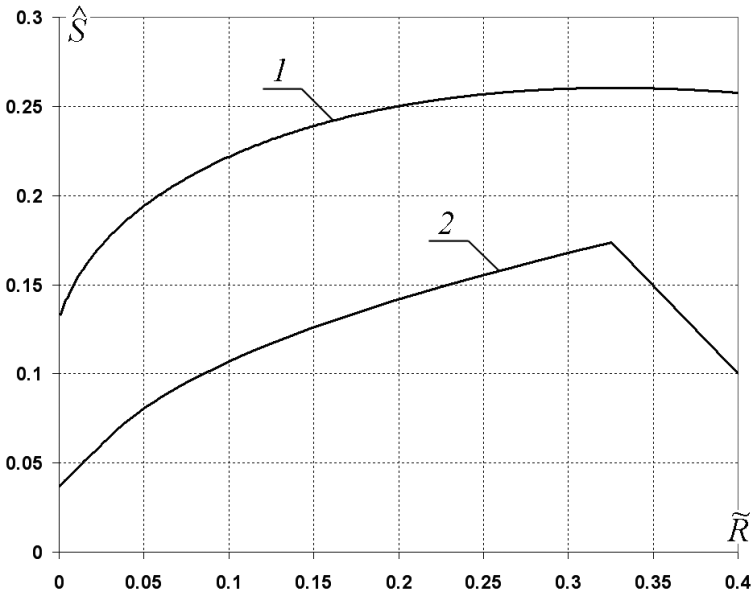

Fig. 3 Comparison VC-estimate with exact bias estimate.

Finally, by combining $\bar{\psi}_1(z)$ and $\bar{\psi}_2(z)$ we obtain the approximation $\bar{\psi}(z)$ for $\psi(z)$. The relative error $\Delta(z) = \frac{\bar{\psi}(z)-\psi(z)}{\psi(z)}$ of this approximation does not exceed 0.01.

4 Estimates comparison

Now we are to compare the obtained exact estimates of empirical risk bias with the complexity based estimates by Vapnik and Chervonenkis.

Let us denote $H(\tilde{p}, p) = \tilde{p} \ln \frac{\tilde{p}}{p} + (1-\tilde{p}) \ln \frac{1-\tilde{p}}{1-p}$ – an entropy, L – a number of decision rules in the set Λ.

When $N \to \infty$, $\varkappa = \frac{N}{\ln L} = const$ the VC-estimates are determined from equation

$$H(\widetilde{F}_0, \hat{F}_{VC}(\widetilde{F}_0)) = \frac{1}{\varkappa} \tag{5}$$

The solution $\hat{F}_{VC}(\widetilde{F}_0)$ of this equation appears to be unimproved (in general case) asymptotical estimate of risk based on empirical risk.

For histogram classifier we have $L = 2^k$ or $\varkappa = \frac{N}{k \ln 2}$. By substitution it into (5) one obtain risk estimate that may be written in the form of bias

$$\hat{S}_{VC}(\widetilde{F}_0) = \hat{F}_{VC}(\widetilde{F}_0) - \widetilde{F}_0.$$

Figure 3 shows the plots: 1 – VC-estimate $\hat{S}_{VC}(\widetilde{F}_0)$ and 2 – exact bias estimate $\hat{S}(\widetilde{F}_0)$ by $\frac{N}{k} = 5$. This comparison provides apprehension on tightness of VC-estimates.

5 Numerical evaluation

In the case of continuous features space it is possible to construct probability distributions that are "similar" to the distributions that provide maximal bias of empirical risk for histogram classifier.

We set out to analyze the distributions that maximize the empirical risk bias. The distributions are obtained by maximizing the expected risk by fixed $\widetilde{F}_0$ or by minimizing the expected empirical risk by fixed expected risk.

Consider first the change in distribution that delivers the maximal bias in histogram classifier case in respect to changes in F_0.

When $F_0 = 0.5$ the minimum of $\widetilde{F}$ is reached for the uniform distribution on D, i.e. by $\alpha_j = \frac{1}{k}$, $p_j = 0.5$.

When F_0 decreases all the probabilities p_j stay equal to 0.5, except one of them, say p_k, that has to be 0 or 1. The probability α_k that is redistributed to this "cell" increases according to the reduction of F_0.

When F_0 decreases further the α_k grows and α' decreases to $\frac{1}{N}$. Then α' stops decreasing, but p' starts changing.

Note that resulting distributions are characterized by the fact that the space X is split into two subsets: the first has zero Bayesian risk level, and the second for which the Bayesian misclassification probability is substantial.

Such peculiar feature of the distribution can be easily provided in continuous space as well.

Let $X = [0,1]^n$ be n-dimensional hypercube with uniform probabilistic distribution.

To specify probabilistic measure P on D one also needs to assign $g(x) = \mathsf{P}(y = 1|x)$ – conditional probability that an object belongs to the first class when its coordinates are x.

Let us construct $g(x)$ in the form

$$g(x) = \begin{cases} g_1, & x_j < \delta, j = 1, \ldots, n \\ g_2, & otherwise \end{cases}, \qquad \delta = \vartheta^{\frac{1}{n}}.$$

In another words, $g(x)$ is piece-wise constant with the two areas of constancy: hypercube of volume ϑ, and it's supplement to the hypercube of volume 1.

Let us assign the first subclass of distributions (call them as model A) by the following: $g_2 = 1$; parameter ϑ is equal to some constant ϑ_0 and g_1 varies from 0 to 0.5; or $g_1 = 0.5$ and ϑ varies from ϑ_0 to 0.

Note that this distributions are constructed "by similarity pattern" of distributions those provide maximal bias of empirical risk for histogram classifier.

For the sake of comparison we shall also consider one more subclass of distributions (call it as model B), that is defined by the following: $\vartheta = 0.5$, $g_1 = g'$, $g_2 = 1 - g'$, where g' is a Bayesian risk level and varies from 0 to 0.5.

Figure 4 shows the results of statistical simulation of classification by decision trees. The greedy method of tree construction was used [2]. Here: 1 – the estimate $\bar{\psi}(z)$ for $M = 4$; 2 – modeling on distributions of model A with $\vartheta_0 = 0.83$, 3 – modeling on distributions of model B.

The distributions from the model A delivers greater risk bias than any other distribution that have been examined.

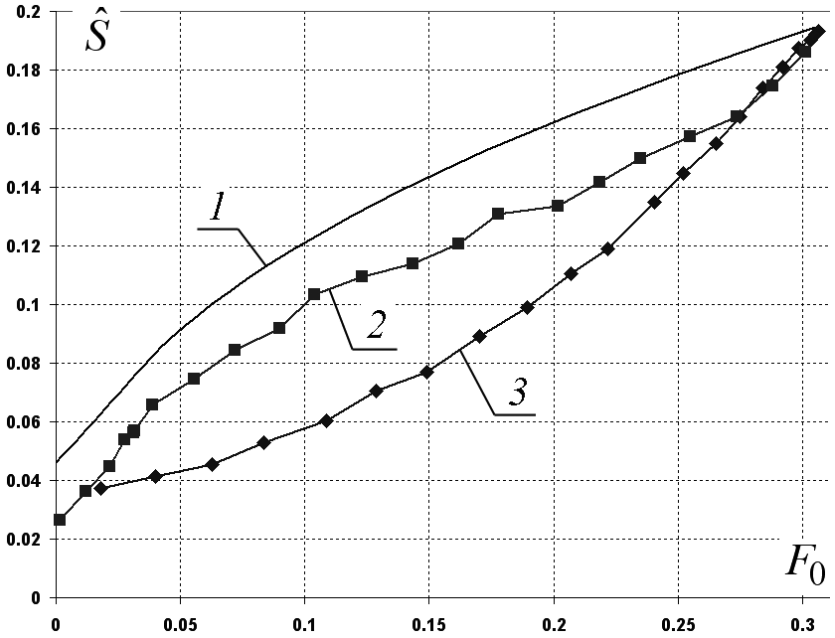

Fig. 4 Empirical risk bias estimated via statistical simulation.

6 Empirical confidence intervals

The constructed classes of distributions can be useful for construction of empirical confidence intervals [6] for risk.

A confidence interval for R will be in the form $[0, \hat{R}(V)]$.

We use only one-sided estimates because usually one has no need in the lower-bound risk estimates. So the construction of a confidence interval is equivalent to choosing function $\hat{R}(V)$ that will be called the estimating function.

For $\hat{R}(V)$ the following condition must be held for any c:

$$\mathsf{P}(R \leq \hat{R}(V)) \geq \eta \tag{6}$$

where η is a given confidence probability.

Note that a confidence interval is built for given algorithm Q.

Known risk estimates are usually constructed not as immediate functions of a sample, but via superposition $\hat{R}(V) = R_e(\bar{R}(V))$, i.e. as a function of some empirical functional $\bar{R}(V)$, that may be, for example, empirical risk or leave-one-out rate.

Empirical functional here plays a role of a point estimate, that being a base to construct an interval estimate.

Analytical estimation of a confidence probability appears to be problematical in practice, since it requires calculating the infimum over the all distributions (all probabilistic measures on $\mathfrak{B}$), therefore constructing empirical bounds is quite desirable.

By empirical estimation here we mean the estimating function that is obtained via the estimation of the minimal confidence probability over some heuristically

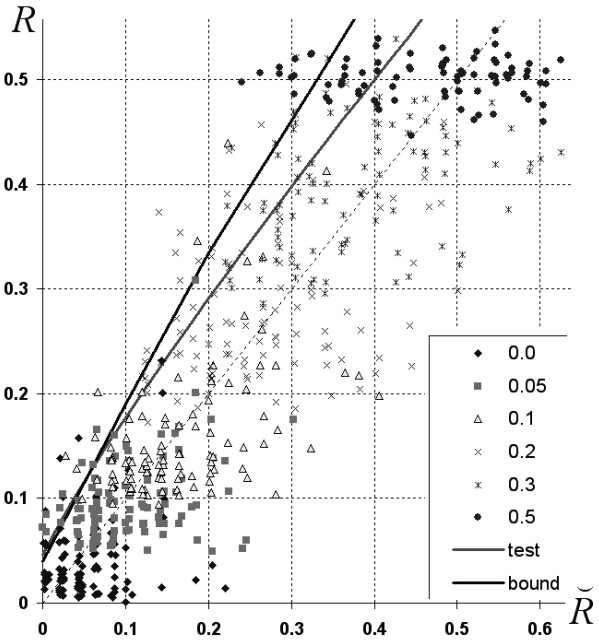

Fig. 5 Empirical bounds for risk by $\eta = 0.9$, built by leave-one-out estimate.

chosen finite set of distributions. If such set is "wide" enough, one may believe that the estimation is valid. As one has been unable to find a distribution that violates the estimate through a dedicated effort, one can expect that the distribution in real world examples will not violate the confidence bound either.

On figure 5 the empirical bounds for risk are shown when the number of terminal nodes in tree is equal to 3, sample size $N = 50$ and space dimensionality $n = 2$. As distributions for modeling the parametrical set of distributions was chosen, where P is uniform in the hypercube $[0,1]^n$ and $\mathsf{P}(y = 1|x) = \begin{cases} g', & x \in [0,\delta]^n \\ 1 - g', & x \notin [0,\delta]^n \end{cases}$. Here $\delta = 2^{\frac{1}{n}}$ and the parameter g' defines a Bayesian error value which is equal in this case to misclassification probability for an optimal decision tree.

7 Conclusions

In this paper, we considered the problem of constructing estimations for the probability of misclassification. We found the maximum bias of empirical risk for the histogram classifier. We found simple approximation formulas for this quantity.

We established that for histogram classifier, the "worst" distribution (which maximizes the bias of empirical risk) is a mixture of the uniform (in X) and an impulse distribution (concentrated in one point).

Similar type of distributions can be easily constructed in the space of continuous variables. Results of statistical modeling for the problem of classification with decision trees suggest that the maximum bias of empirical risk can be attained

as well with other (besides the histogram classifier) methods of classification, allowing, in particular, to build more accurate empirical confidence intervals for the risk.

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